


<b>Search Notes</b>  	<b>Application/Control No.</b>  10530307	<b>Applicant(s)/Patent Under Reexamination</b>  BHAT ET AL.
	<b>Examiner</b>  Lee, Siu M	<b>Art Unit</b>  2611

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
375	148, 316, 345, 346	11/06/2007	Siu M. Lee

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST	11/06/07	Siu M. Lee
Discuss the application with Chieh Fan	11/06/07	Siu M. Lee

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>